

LM74681 100V Ideal Diode Bridge Controller for PoE Powered Applications

1 Features

- Input operating voltage range: 30V to 90V
 - 100V absolute maximum
- 4× integrated gate drive control
- 165µA gate pull-up strength
- 100mA gate pull-down strength
- Ultra-low quiescent current of 0.27µA during detection and classification phase $(V_{IN1-IN2} < 23V)$
- Linear gate regulation control for supply ORing applications
 - V_{TG} $_{REG}$ = 11mV
- Enable pin for user controlled device on/off
- -40°C to 125°C operating junction temperature
- Small footprint: 3mm × 3mm WSON-12
 - Meets IPC-9592 spacing rules

2 Applications

- PoE powered devices (48V)
- Video surveillance: IP cameras
- Polarity agnostic power inputs

OUTP EN TG1 IN1 IN2 LM74681 Cout BG2 BG1 GND

Typical Application Schematic

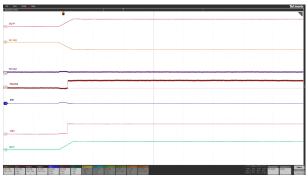
3 Description

The LM74681 is a 100V ideal diode bridge controller capable of driving a MOSFET bridge, enabling efficient low-loss bridge rectifier solutions in Power over Ethernet (PoE) applications. It allows a Power over Ethernet, powered device (PD) to receive power from RJ-45 data pairs, spare pairs, or any combination of the two, regardless of voltage polarity. The integrated charge pump allows use of N-channel MOSFETs, which are smaller and more cost effective than P-channel MOSFETs for the same power level. The LM74681 along with N-channel MOSFET bridge can replace the conventional diode bridge and can be conveniently implemented in both 2-pair and 4pair PoE PD systems. In the event of a power source failure or short circuit, a rapid turn-off feature reduces reverse current spikes. The device also features an ultra-low quiescent current of 0.27µA, which ensures that there is no data corruption during the PoE PD detection and classification phase. This device is characterized for operation over a junction temperature range of -40°C to +125°C.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾				
LM74681	DRR (WSON, 12)	3mm × 3mm				

- For all available packages, see the orderable addendum at the end of the data sheet.
- The package size (length × width) is a nominal value and includes pins, where applicable.



-48V DC Input, Startup With Vin Ramp



Table of Contents

1 Features	7.4 Device Functional Modes1
2 Applications	8 Application and Implementation1
3 Description	8.1 Application Information1
4 Pin Configuration and Functions	
5 Specifications	8.3 Powered Device for IEEE 802.3bt Class 5-8
5.1 Absolute Maximum Ratings	
5.2 ESD Ratings	
5.3 Recommended Operating Conditions	
5.4 Thermal Information	9 Device and Documentation Support1
5.5 Electrical Characteristics	9.1 Receiving Notification of Documentation Updates1
5.6 Switching Characteristics	9.2 Support Resources19
5.7 Typical Characteristics	7 9.3 Trademarks19
6 Parameter Measurement Information	
7 Detailed Description1	
7.1 Overview1	
7.2 Functional Block Diagram1	
7.3 Feature Description1	



4 Pin Configuration and Functions

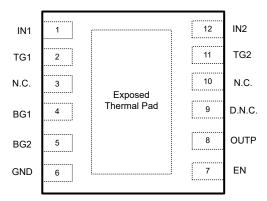


Figure 4-1. DRR Package, 12-Pin WSON (Top View)

Table 4-1. Pin Functions

NO. NAME		I/O ⁽¹⁾	DESCRIPTION
		1/0(*)	DESCRIPTION
1	IN1	I	Bridge rectifier input 1. Connect to top side MOSFET Q1 source and bottom side MOSFET Q4 drain.
2	TG1	0	Top side MOSFET gate drive 1.
3	N.C.	_	No connection.
4	BG1	0	Bottom side MOSFET gate drive 1.
5	BG2	0	Bottom side MOSFET gate drive 2.
6	GND	G	Device ground. Connect to bottom side MOSFETs Q3 and Q4 source and output ground.
7	EN	I	Enable pin. Can be connected to OUTP for always ON operation.
8	OUTP	I	Bridge rectifier output. Connect to top side MOSFETs Q1 and Q2 drain. Connect a minimum of 0.1µF between OUTP and GND close to the IC.
9	D.N.C.	_	No connection. Do not connect externally.
10	N.C.	_	No connection.
11	TG2	0	Top side MOSFET gate drive 2.
12	IN2	I	Bridge rectifier input 2. Connect to top side MOSFET Q2 source and bottom side MOSFET Q3 drain.

⁽¹⁾ I = Input, O = Output, G = GND



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
	OUTP to GND	-0.3	100	
Input Pins	IN1, IN2 to GND	-2	OUTP+2	V
IIIput FIIIs	EN to GND	-0.3	OUTP	V
	IN1-IN2	-100	100	
Output Pins	BG1, BG2 to GND	-0.3	15	V
Output Pilis	TG1 to IN1 and TG2 to IN2	-0.3	15	V
Operating junction temperature ⁽²⁾		-40	150	°C
Storage temperatu	Storage temperature, T _{stg}		150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001 ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JS-002 ⁽²⁾	±500	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	NOM MAX	UNIT
Input Ding	OUTP to GND	30	90	V
Input Pins	EN to GND	0	OUTP	V
Input to Output pins	OUTP to INx	-90		V
External MOSFET max V _{GS} rating	GATE to SOURCE	15		V
TJ	Operating junction temperature range ⁽²⁾	-40	150	°C

Recommended Operating Conditions are conditions under which the device is intended to be functional. For specifications and test conditions, see Section 5.5.

5.4 Thermal Information

		LM7468x		
	THERMAL METRIC(1)	DRR (WSON)	UNIT	
		12 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	60.9	°C/W	
R _{0JC(top)}	Junction-to-case (top) thermal resistance	48	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	31.5	°C/W	
Ψ_{JT}	Junction-to-top characterization parameter	1.2	°C/W	
Ψ_{JB}	Junction-to-board characterization parameter	31.4	°C/W	

Product Folder Links: LM74681

⁽²⁾ High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

⁽²⁾ High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.



5.4 Thermal Information (continued)

		LM7468x	
THERMAL METRIC ⁽¹⁾		DRR (WSON)	UNIT
		12 PINS	
R ₀ JC(bot)	Junction-to-case (bottom) thermal resistance	7.1	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

5.5 Electrical Characteristics

 $T_J = -40^{\circ}\text{C}$ to +125°C; typical values at $T_J = 25^{\circ}\text{C}$, OUTP = 48 V, $V_{(EN)} = \text{OUTP}$, C_{OUT} : 1uF over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
SUPPLY VOLTAG	SUPPLY VOLTAGE							
V _{OUTP}	OUTP voltage range		30		90	V		
V _{OUT_UVLOR}			24.9	27.6	29.5	V		
V _{OUT_UVLOF}			24	26.7	28.5	V		
V _{OUT_UVLO_Hyst}				0.9		V		
IQ	Operating Quiescent Current	V _{EN} = 3.3V, V _{OUTP} = 48V, I _{GND}		270	450	μA		
	Shutdown Supply Current	V _{EN} = 0 V, V _{OUTP} = 48 V		12.8	15	μΑ		
I _{SHDN}	UVLO shutdown current (detection phase)	2.7 V ≤ V _{OUTP} ≤ 10.1 V		0.27	3.8	μΑ		
	UVLO shutdown current (classification phase)	10.2 V ≤ V _{OUTP} ≤ 23 V		0.27	3.8	μA		
ENABLE INPUT								
V _{EN_IL}	Enable input low threshold		0.413	0.7	0.96	V		
V _{EN_IH}	Enable input high threshold		0.631	0.9	1.15	V		
V _{EN_Hys}	Enable Hysteresis			0.2		V		
I _{EN}	Enable pin leakage current	V _(EN) = 48 V		87	241	nA		
V _{IN} to V _{OUTP}	,				'			
V_{FWD}	Threshold for forward conduction		169	195	226	mV		
V _{REV}	Threshold for reverse current blocking		-17	-11	-5	mV		
V _{TG_REG}	Top side gate drive regulation voltage		7	11	16	mV		
V _{TG_REG_SINK}	Top side regulation sink current		5	10	16	μA		
V _{TG_FC}	Full conduction threshold			56		mV		
GATE DRIVE								
$V_{TGx} - V_{INx}$	Top Gate Drive Voltage		8.7	10	11.1	V		
$V_{BGx} - V_{GND}$	Bottom Gate Drive Voltage		11.96	13	13.85	V		
L	Peak source current	$V_{INx} - V_{GND} = 100 \text{ mV},$ $V_{TGx} - V_{INx} = 5 \text{ V}$	124	165	210	μA		
I _{TGx}	Peak sink current	$V_{INx} - V_{GND} = -50 \text{ mV},$ $V_{TGx} - V_{INx} = 5 \text{ V}$		100		mA		
1	Peak source current	$V_{BGx} - V_{GND} = 5 V$	2.3	3.7	5	mA		
I _{BGx}	Peak sink current	V _{BGx} – V _{GND} = 5 V		80		mA		

Copyright © 2024 Texas Instruments Incorporated

Submit Document Feedback



5.6 Switching Characteristics

 T_J = -40°C to +125°C; typical values at T_J = 25°C, OUTP = 48 V, $V_{(EN)}$ = OUTP, C_{OUT} : 1uF over operating free-air temperature range (unless otherwise noted)

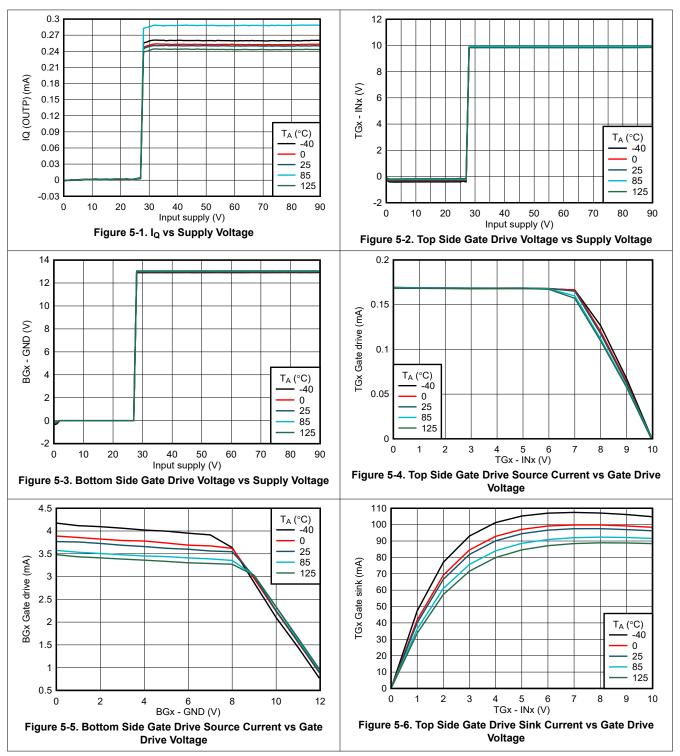
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
EN _{TDLY}	Enable (low to high) to TGx Turn On delay			170	265	μs
EN _{TDLY}	Enable (low to high) to BGx Turn On delay			6	9.5	μs
t _{Reverse delay}	Reverse voltage detection to TGx Turn Off delay	V _(IN) – V _(OUTP) = 100 mV to –100 mV		2	3	μs
t _{Forward recovery}	Forward voltage detection to TGx Turn On delay	$V_{(IN)} - V_{(OUTP)} = -100 \text{ mV to } 700 \text{ mV}$		5	9.1	μs

Product Folder Links: LM74681

6

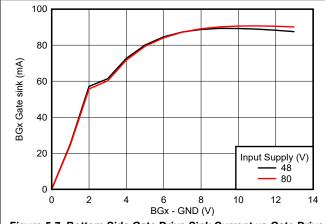


5.7 Typical Characteristics





5.7 Typical Characteristics (continued)





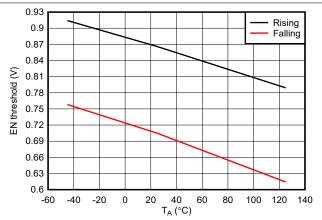


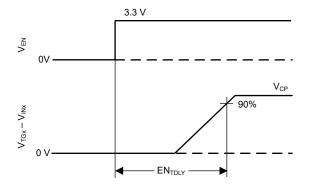
Figure 5-8. Enable Threshold vs Temperature

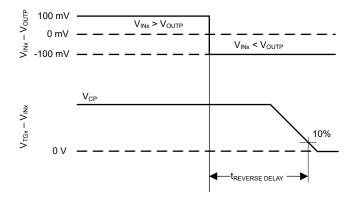
Submit Document Feedback

Copyright © 2024 Texas Instruments Incorporated



6 Parameter Measurement Information





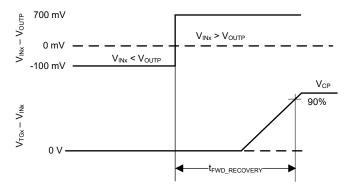


Figure 6-1. Timing Waveforms



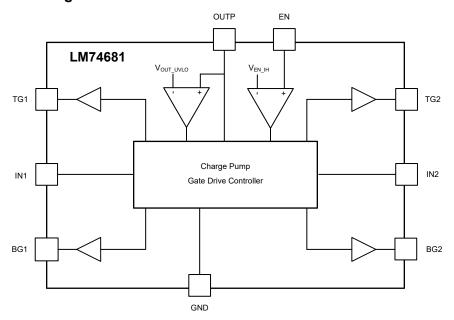
7 Detailed Description

7.1 Overview

The LM74681 is an ideal diode bridge controller designed to meet input rectifier requirements in PoE PD applications. A very common application is an IEEE 802.3 powered device, which is required to accept voltage in either polarity at its RJ-45 input (polarity agnostics input). Traditional diode bridges have lower efficiency due to the forward drop generated across two conducting diodes. Schottky diode based bridge rectifier offer lower forward drop compared to standard diode bridge however the schottky bridge may not be suitable for high temperature applications. Schottky diode bridges exhibit temperature induced leakage currents. These leakage currents have a voltage dependency that can invalidate the measured detection signature. In addition, these leakage currents can back-feed through the unpowered branch and the unused bridge, violating IEEE 802.3 specifications. Ideal diode bridge circuits are often implemented with discrete components such as a combination of P-channel and N-channel MOSFETs. These bridges usually exhibit poorer performance in terms of quiescent current, transient immunity against supply transients, and wider variation in leakage currents over temperature.

LM74681 offers integrated gate control for the external MOSFET bridge to realize low-loss rectifier solution for PoE PD applications. This device can handle transient voltages up to 100V, which makes it suitable to meet voltage transient requirements in 48V PoE powered applications. LM74681 features a linear ORing gate control mechanism that stops the powered device from allowing current to back-feed into the Ethernet cable. It also incorporates a built-in under-voltage lockout (UVLO) feature to ensure ultra-low quiescent current during both PoE PD detection (VIN < 10.5V) and classification phases (VIN < 20.5V).

7.2 Functional Block Diagram



Product Folder Links: LM74681

Copyright © 2024 Texas Instruments Incorporated



7.3 Feature Description

7.3.1 Input and Output Voltage

LM74681 supports power sources with wide input voltage range enabling polarity-agnostic power source to be connected to its IN1 and IN2 pins. LM74681 is designed to operate with IN1 and IN2 designed to vary from 90V to -90V. The LM74681 device includes an OUTP UVLO feature that enables it to consume extremely low quiescent current, around $0.27\mu\text{A}$, when the OUTP voltage is below $V_{\text{OUTP_UVLO}}$. This capability guarantees that data corruption does not occur during the Power over Ethernet (PoE) Powered Device (PD) detection and classification stage.

The OUTP pin is used to power the internal circuitry of LM74681, typically drawing I_Q when enabled and I_{SHDN} when disabled. If the OUTP pin voltage is greater than the V_{OUTP_UVLO} rising threshold, then LM74681 operates in either shutdown mode or active mode in as per the EN pin voltage. LM74681 supports an OUTP voltage of up to 90V during normal operation and can withstand voltage transients up to 100V ensuring protection against surges.

7.3.2 Charge Pump

The internal charge pump supplies the voltage necessary to drive the gate of the external N-channel MOSFETs. The charge pump is activated once the EN pin voltage is above the specified input high threshold, V_{EN_IH} . If EN pin is pulled low, then the charge pump remains disabled. By enabling and disabling the charge pump, the operating quiescent current of the LM74681 can be optimized as per system requirements.

7.3.3 Gate Driver

The gate drivers are used to control the external N-Channel MOSFETs by setting the GATE to SOURCE voltage to the corresponding mode of operation. The FETs on the top side Q1 and Q2 are driven by gates TG1 and TG2 and the FETs on the bottom side Q3 and Q4 are driven by gates BG1 and BG2 respectively.

The internal charge pump powers the top side gate drivers and depending on the DRAIN to SOURCE voltage of each MOSFET, LM74681 has three defined modes of operation the gate driver operates under which are forward regulation, full conduction mode and reverse current protection. These modes are described in more detail in Section 7.4.1.1, Section 7.4.1.2, and Section 7.4.2. Figure 7-1 depicts how the modes of operation vary according to the DRAIN to SOURCE voltage. The threshold between forward regulation and conduction modes is when the DRAIN to SOURCE voltage is V_{TG_REG}. The threshold between forward regulation mode and reverse current protection mode is when the DRAIN to SOURCE voltage is V_{REV}.

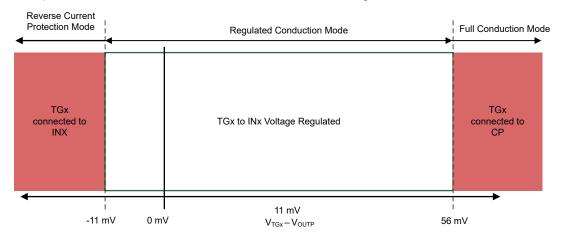


Figure 7-1. Gate Driver Mode Transitions

The bottom-side gate drivers of the LM74681 are powered directly from the IN1 or IN2 voltage and operate in two distinct modes which are forward full conduction and reverse current blocking. These gate drivers are controlled by below logic to ensure efficient power flow and protection against reverse current.

• BG1 is enabled and in full conduction when the voltage at IN1 is greater than that GND+2V and is disabled when IN1 falls below IN2 to block reverse current flow.



• Similarly, BG2 is enabled when IN2 exceeds GND+2V and is disabled when IN2 is lower than IN1.

7.3.4 Enable

The enable pin allows for the gate driver to be either enabled or disabled by an external signal. If the EN pin voltage is greater than the rising threshold, the gate drivers and charge pump operates as described in Section 7.3.3 and Section 7.3.2. If the enable pin voltage is less than the input low threshold, the charge pump and gate drivers are disabled placing the LM74681 in shutdown mode. The EN pin to be connected directly to the OUTP pin if enable control is not needed.

7.4 Device Functional Modes

7.4.1 Conduction Mode

Conduction mode occurs when the top gate drivers are enabled and there are two regions of operating in this mode based on the source to drain voltage of the FETs driven by LM74681. The modes are described in Section 7.4.1.1 and Section 7.4.1.2.

7.4.1.1 Regulated Conduction Mode

For the LM74681 to operate its top gates TG1 and TG2 in regulated conduction mode, the gate driver must be enabled as described in Section 7.3.3 and the current from source to drain of the external MOSFET must be within the range to result in an INx to OUTP voltage drop of V_{REV} to V_{TG_FC} . During forward regulation mode, the INx to OUTP voltage is regulated to V_{TG_REG} by adjusting the gate to source voltage. This closed loop regulation scheme enables graceful turn-off of the MOSFET at very light loads and ensures zero DC reverse current flow.

7.4.1.2 Full Conduction Mode

For the LM74681 to operate its top gates TG1 and TG2 in full conduction mode the gate driver must be enabled as described in Section 7.3.3 and the current from source to drain of the external MOSFET must be large enough to result in an INx to OUTP voltage drop of greater than V_{TG_FC} . If these conditions are achieved the GATE pin is internally connected to the charge pump resulting in the INx to OUTP voltage being equal to $V_{TGx} - V_{INx}$. By connecting the internal charge pump to GATE the external MOSFET $R_{DS(ON)}$ is minimized reducing the power loss of the external MOSFET when forward currents are large.

7.4.2 Reverse Current Protection Mode

For the LM74681 to operate in reverse current protection mode, the gate driver must be enabled as described in Section 7.3.3 and the current of the external MOSFET must be flowing from the drain to the source. When the INx to OUTP voltage is typically less than V_{REV} , reverse current protection mode is entered and the FET gates is internally connected to the source. This connection of the TGx to INx pin disables the external MOSFET. The body diode of the MOSFET blocks any reverse current from flowing from the drain to source.

Product Folder Links: *LM74681*



8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The LM74681 drives four external N-channel MOSFETs in a diode bridge configuration, making it ideal for rectifying power supplies of any polarity. By replacing traditional diodes with MOSFETs, the device minimizes conduction losses, resulting in improved thermal performance and increased overall system efficiency. OUTP UVLO feature of LM74681 makes it suitable for Power over Ethernet (PoE) applications. The schematic for a 48V POE PD application is shown in Figure 8-1 where the LM74681 is driving the high side MOSFETs Q1, Q2 and low side MOSFETs Q3, Q4 in diode bridge configuration.

8.2 Typical Application

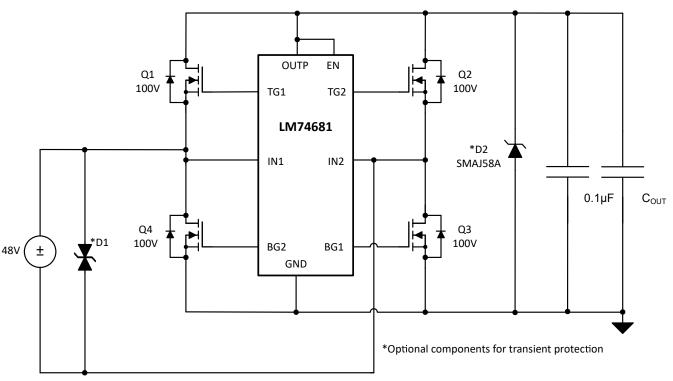


Figure 8-1. Typical Application Circuit

8.2.1 Design Requirements

A design example, with system design parameters listed in Table 8-1 is presented.

Table 8-1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Application	PoE PD input IEEE 802.3at
Input voltage range	44V to 57V
Input Power	30W

Copyright © 2024 Texas Instruments Incorporated

Submit Document Feedback

8.2.2 Detailed Design Procedure

8.2.2.1 Design Considerations

- Input operating voltage range, including line transients
- Maximum load current
- **Output Capacitance**

8.2.2.2 MOSFET Selection

The important MOSFET electrical parameters are the maximum continuous drain current I_D, the maximum drain-to-source voltage V_{DS(MAX)}, the maximum gate-to-source voltage V_{GS(MAX)}, and the drain-to-source On resistance R_{DS(ON)}.

The V_{DS(MAX)} rating of the MOSFET must be high enough to withstand the highest differential voltage seen in the application, including any anticipated transients during fault conditions. For a 48V PoE application, a MOSFET with a voltage rating of 100V is recommended. The LM74681 can drive a maximum gate-to-source voltage of 13.8V. A MOSFET with a minimum V_{GS(MAX)} rating of 15V should be selected. For MOSFETs with lower V_{GS} ratings, a Zener diode can be used to clamp the voltage to a safe level.

The MOSFET ID rating must exceed the maximum continuous load current to ensure reliable operation under full load conditions. Additionally, the MOSFET thermal resistance should be considered to ensure the junction temperature (T_I) remains within safe limits under the expected maximum power dissipation including the initial inrush phase when the output capacitors are charged through the MOSFETs body diode.

To reduce the MOSFET conduction losses, the lowest possible R_{DS(ON)} is preferred, but selecting a MOSFET based on low R_{DS(ON)} may not always be beneficial. Higher R_{DS(ON)} will provide increased voltage information to the LM74681 reverse comparator at a lower reverse current. Reverse current detection is better with increased $R_{DS(ON)}$. Choosing a MOSFET with $R_{DS(ON)}$ that develops <30mV forward voltage drop at maximum current is a good starting point. Usually, R_{DS(ON)} increases drastically below 4.5V V_{GS} and R_{DS(ON)} is highest when V_{GS} is close to MOSFET Vth. For stable regulation at light load conditions, it is recommended to operate the MOSFET close to 4.5V V_{GS}, that is, much higher than the MOSFET gate threshold voltage. It is recommended to choose MOSFET gate threshold voltage V_{th} of 2.5V to 3.5V maximum. Choosing a lower V_{th} MOSFET also reduces the turn ON time.

PSMN040-100MSE N-channel MOSFET is selected to meet this 48V PoE PD bridge rectifier design and it is rated at:

- V_{DS(MAX)}: 100V
- V_{GS(MAX)}: ±20V
- $R_{DS(ON)}$: 29.4m $\!\Omega$ (typical) and 36.6m $\!\Omega$ (maximum) at 10V V_{GS}

8.2.2.3 Output capacitance

A minimum ceramic capacitor of 0.1µF is recommended to be placed across the OUTP and GND pins as close to the LM74681 as possible for decoupling. Additional output capacitance C_{OUT} may be required,

Product Folder Links: LM74681

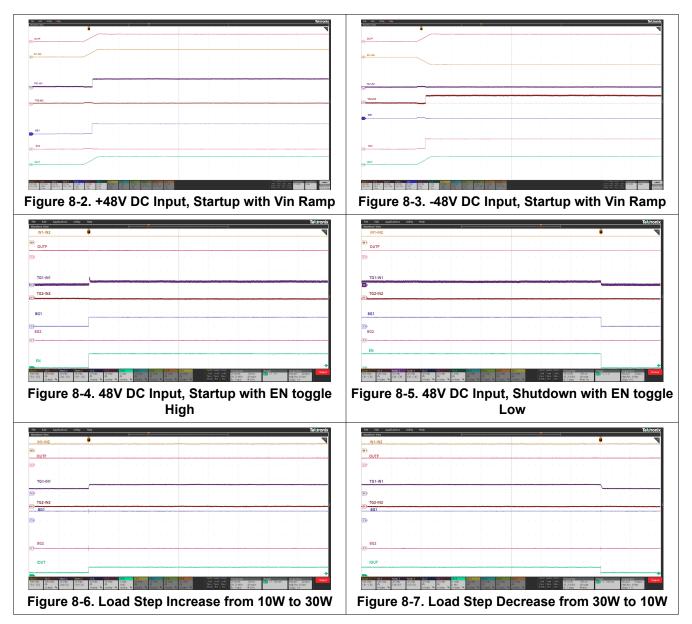
- Downstream DC-DC converter input capacitance requirement
- To ensure that the rectified output voltage remains stable during load transients
- To smooth the output voltage and reduce ripple to acceptable level

Submit Document Feedback

Copyright © 2024 Texas Instruments Incorporated



8.2.3 Application Curves



8.3 Powered Device for IEEE 802.3bt Class 5-8 (45W-90W) Systems

In PoE PD applications requiring greater than 30W power, the IEEE 802.3bt standard recommends the use of a 4-pair cable for efficient power delivery. To support this, two LM74681 controllers can be used to drive two independent N-channel MOSFET based full-bridge rectifiers connected to a common output. Each LM74681 drives one full-bridge rectifier, enabling power rectification from the two separate 2-pair power paths provided by the 4-pair cable. This approach ensures compliance with the higher power delivery capabilities of the IEEE 802.3bt standard while maintaining high efficiency.

The linear ORing gate control mechanism of LM74681 actively drives the MOSFET gates, allowing forward conduction and reverse current blocking. This prevents backflow between the two power paths and avoids current flow back into the Ethernet cable. By replacing traditional diodes with low R_{DS(ON)} MOSFETs, the LM74681 reduces conduction losses and heat generation, which is critical for high-power PoE systems. The rectified outputs of the two full bridges are combined at the PD input, providing seamless power delivery. This



architecture enables efficient, reliable operation for PoE PD systems requiring high power levels in compliance with IEEE 802.3bt standards.

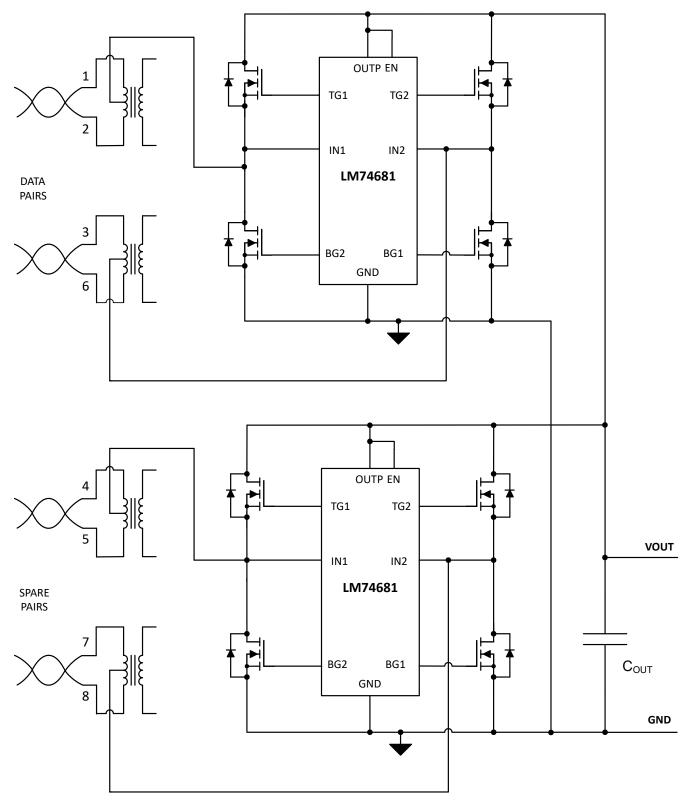


Figure 8-8. Typical PoE PD High Power Application



8.4 Power Supply Recommendations

8.4.1 Transient Protection

The TVS at input or output is not required for the LM74681 to operate, but it may be required to clamp the voltage transients caused by lightning, switching surges, or power disturbances that can exceed the voltage ratings of MOSFETs and the controller possibly causing damage. A TVS diode protects against such events by clamping the transient voltages to safe levels. For 48V PoE PD application, a unidirectional TVS like SMAJ58A with a standoff voltage above the maximum input DC voltage and a clamping voltage below the MOSFET's maximum rating is recommended. This TVS is recommended to be placed as close to the LM74681 as possible. In well-regulated applications with minimal transient risks, a TVS diode may not be necessary.

8.5 Layout

8.5.1 Layout Guidelines

- Place the decoupling capacitor close to the OUTP pin and IC GND.
- For the top side MOSFETs, connect the INx, TGx, and OUTP pins of LM74681 close to the MOSFET SOURCE, GATE, and DRAIN pins.
- The high current path is through the MOSFETs, therefore it is important to use thick and short traces for the source and drain of the MOSFET to minimize resistive losses.
- The TGx and BGx pins of the LM74681 must be connected to the respective MOSFET gate with a short trace.
- Place transient suppression components close to LM74681.
- Obtaining acceptable performance with alternate layout schemes is possible, however the layout shown in the Section 8.5.2 is intended as a guideline and to produce good results.

Copyright © 2024 Texas Instruments Incorporated

Submit Document Feedback



8.5.2 Layout Example

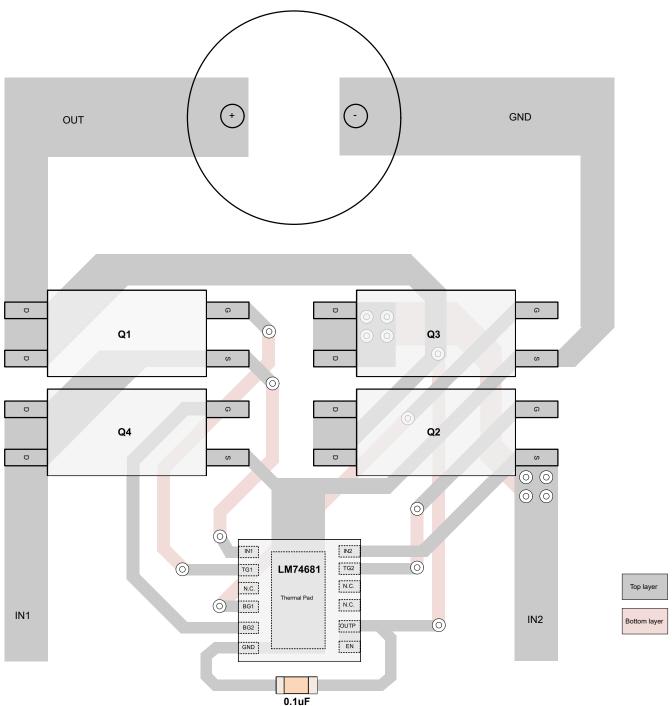


Figure 8-9. LM74681 Example Layout



9 Device and Documentation Support

9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
December 2024	*	Initial Release

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



www.ti.com 18-Dec-2024

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
LM74681DRRR	ACTIVE	WSON	DRR	12	5000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	L74681	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 19-Dec-2024

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

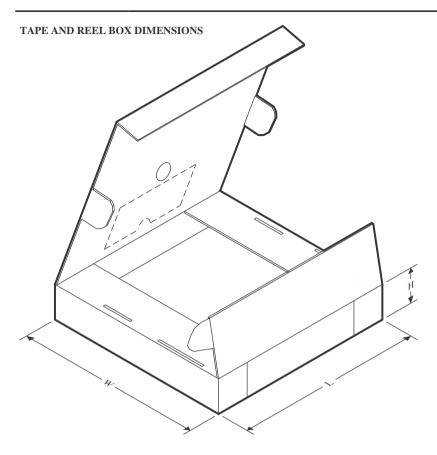
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	U	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM74681DRRR	WSON	DRR	12	5000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

www.ti.com 19-Dec-2024



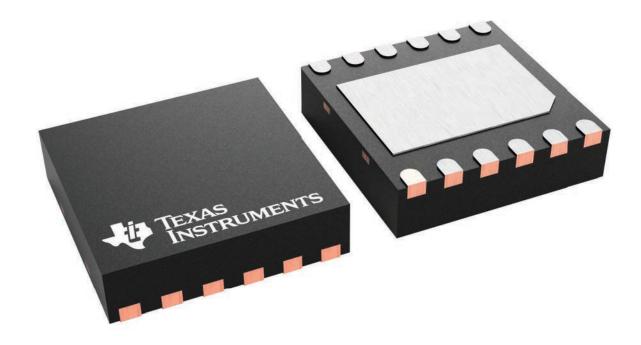
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
LM74681DRRR	WSON	DRR	12	5000	367.0	367.0	35.0	

3 x 3, 0.5 mm pitch

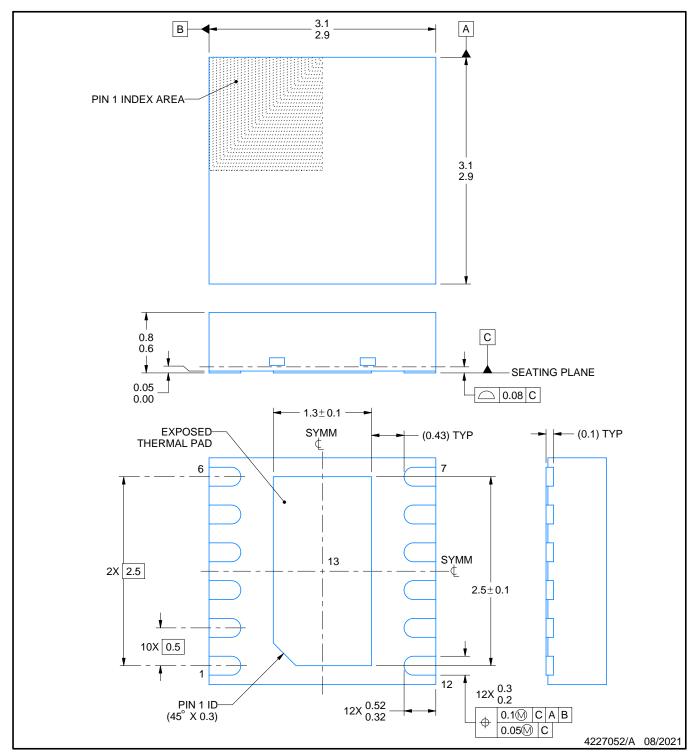
PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





PLASTIC SMALL OUTLINE - NO LEAD

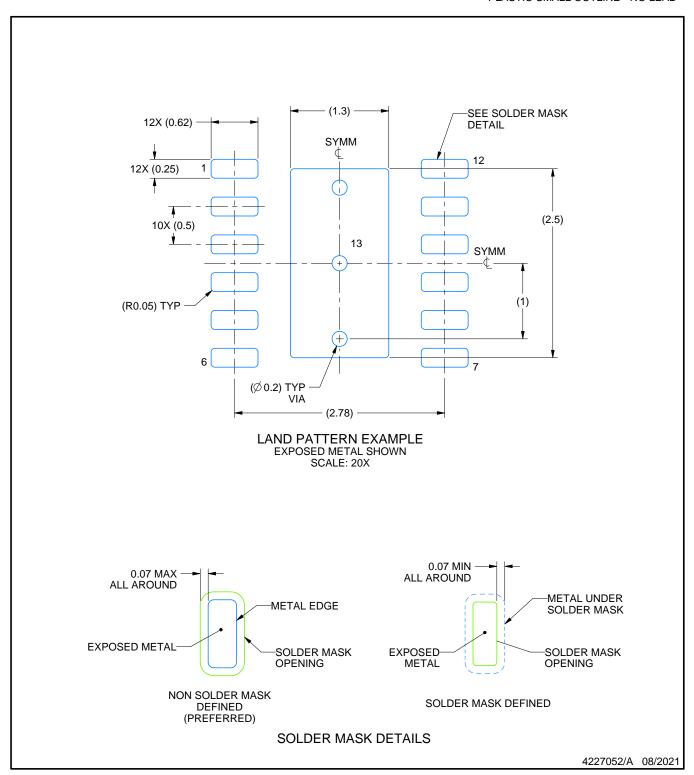


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC SMALL OUTLINE - NO LEAD

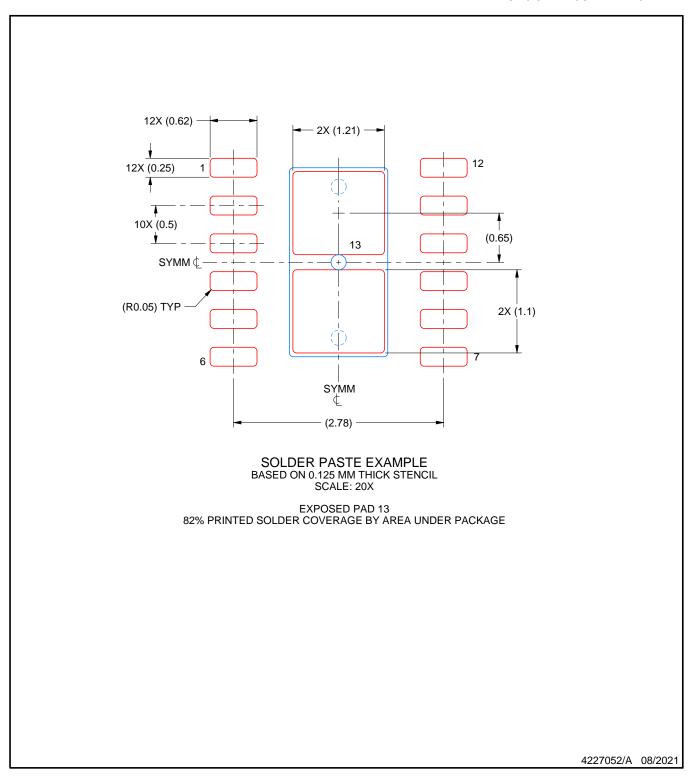


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

^{6.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated